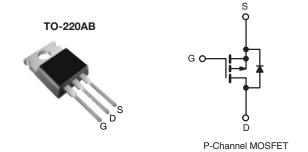


COMPLIANT

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 60			
$R_{DS(on)}(\Omega)$	V _{GS} = - 10 V	0.50		
Q _g (Max.) (nC)	12			
Q _{gs} (nC)	3.8			
Q _{gd} (nC)	5.1			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Load (Dh) from	IRF9Z10PbF
Lead (Pb)-free	SiHF9Z10-E3
SnPb	IRF9Z10
SIPD	SiHF9Z10

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	- 60	V	
Gate-Source Voltage	V_{GS}	± 20	V		
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$		- 6.7	А	
	$T_C = 100 ^{\circ}C$	ID	- 4.7		
Pulsed Drain Current ^a	I _{DM}	- 27			
Linear Derating Factor			0.29	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	140	mJ		
Repetitive Avalanche Current ^a	I _{AR}	- 6.7	А		
Repetitive Avalanche Energy ^a	E _{AR}	4.3	mJ		
Maximum Power Dissipation	T _C = 25 °C	P _D	43	W	
Peak Diode Recovery dV/dt ^c		dV/dt	- 4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	C 20 or M2 corour		10	lbf ⋅ in	
	6-32 or M3 screw		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25$ V, starting $T_J = 25$ °C, L = 6.23 mH, $R_g = 25$ Ω , $I_{AS} = -6.7$ A (see fig. 12).
- c. $I_{SD} \le -6.7 \text{ A}$, $dI/dt \le 90 \text{ A}/\mu s$, $V_{DD} \le V_{DS}$, $T_J \le 175 ^{\circ} \text{C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.5	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA		- 60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = -1 mA		-	- 0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA		- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V V _{DS} = - 48 V, V _{GS} = 0 V, T _J = 150 °C		-	-	- 100 - 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 4.0 A ^b	_	-	0.50	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - 2	25 V, I _D = - 4.0 A ^b	1.4	-	-	S
Dynamic					L	L	l
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	270	-	pF
Output Capacitance	C _{oss}			-	170	-	
Reverse Transfer Capacitance	C _{rss}			-	31	-	
Total Gate Charge	Qg			_	-	12	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{GS} = -10 \text{ V}$ $I_D = -6.7 \text{ A}, V_{DS} = -48 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.8	
Gate-Drain Charge	Q _{gd}			-	-	5.1	
Turn-On Delay Time	t _{d(on)}				11	-	- ns
Rise Time	t _r	V_{DD} = - 30 V, I_{D} = - 6.7 A, R_{g} = 24 Ω , R_{D} = 4.0 Ω , see fig. 10 ^b		-	63	-	
Turn-Off Delay Time	t _{d(off)}			-	10	-	
Fall Time	t _f			-	31	-	
Internal Drain Inductance	L_{D}	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	الم
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		1	1	- 6.7	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 27	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = - 6.7 A, V _{GS} = 0 V ^b		-	-	- 5.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = -6.7 \text{A}, \text{dI/dt} = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	80	160	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.096	0.19	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn		on is do	minated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300 \,\mu\text{s}$; duty cycle $\leq 2 \,\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

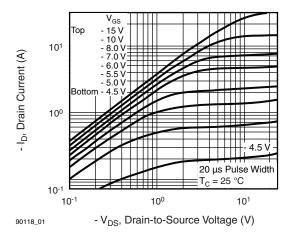


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

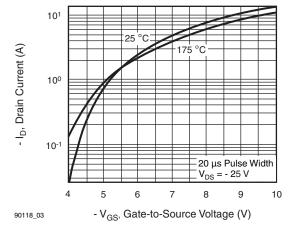


Fig. 3 - Typical Transfer Characteristics

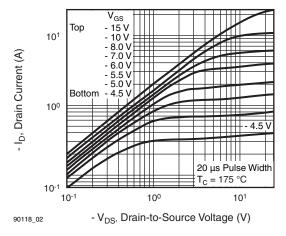


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}$ C

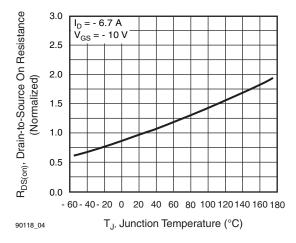


Fig. 4 - Normalized On-Resistance vs. Temperature



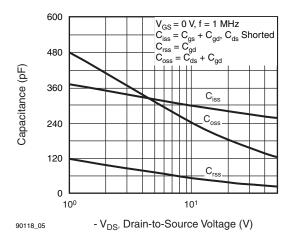


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

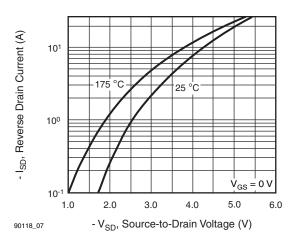


Fig. 7 - Typical Source-Drain Diode Forward Voltage

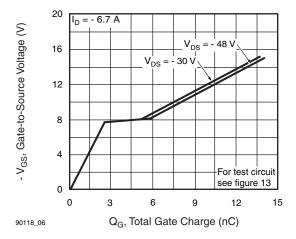


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

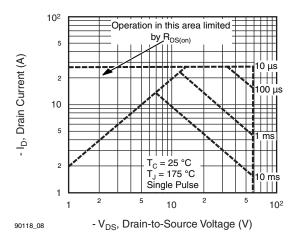


Fig. 8 - Maximum Safe Operating Area





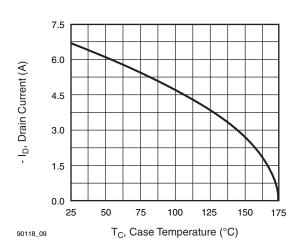


Fig. 9 - Maximum Drain Current vs. Case Temperature

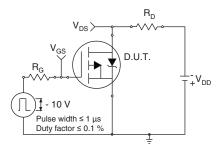


Fig. 10a - Switching Time Test Circuit

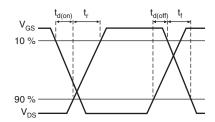


Fig. 10b - Switching Time Waveforms

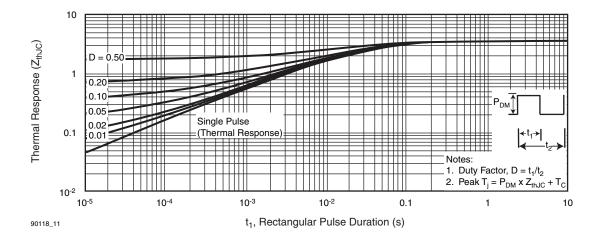


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



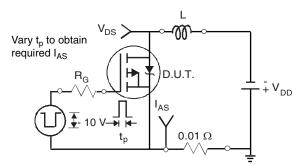


Fig. 12a - Unclamped Inductive Test Circuit

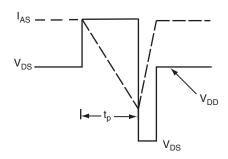


Fig. 12b - Unclamped Inductive Waveforms

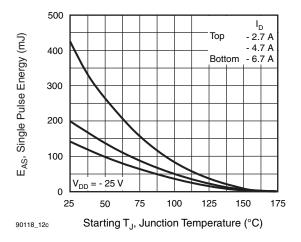


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

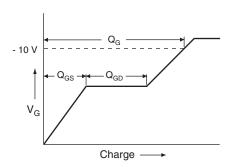


Fig. 13a - Basic Gate Charge Waveform

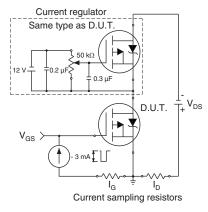
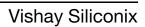
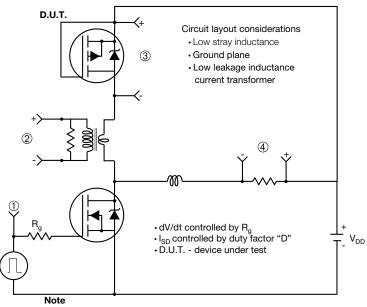


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

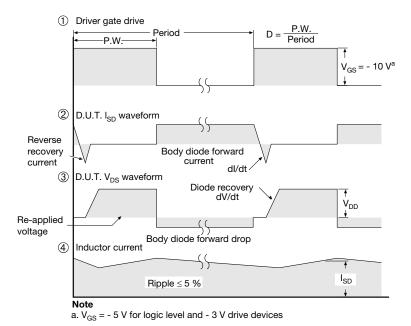


Fig. 14 - For P-Channel

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